Middle Power LED Series Flip Chip Package

LM101B



New technology provides high performance and energy conservation

Features & Benefits

- Greater freedom of design with compact package size
- High degree of reliability with plastic-free structure
- Low thermal resistance
- High efficiency providing optimized solution



Table of Contents

1.	Characteristics	 3
2.	Product Code Information	 6
3.	Typical Characteristics Graphs	 15
4.	Outline Drawing & Dimension	 17
5.	Reliability Test Items & Conditions	 19
6.	Soldering Conditions	 20
7.	Tape & Reel	 21
8.	Label Structure	 23
9.	Packing Structure	 24
10.	Precautions in Handling & Use	 26

1. Characteristics

a) Absolute Maximum Rating

ltem	Symbol	Rating	Unit	Condition
Operating Temperature	Ta	-40 ~ +105	٥C	-
Storage Temperature	T _{stg}	-40 ~ +120	٥C	-
LED Junction Temperature	Tj	125	٥C	-
Forward Current	lF	350	mA	-
Assembly Process Temperature	-	260 <10	°C S	-
ESD (HBM)	-	±2	kV	-

Note:

Proper current derating must be observed to maintain junction temperature below the maximum at all time.

It is recommended minimum current 10mA in order to avoid un-even brightness, and may vary depending on circuit configuration.

b) Electro-optical Characteristics ($I_F = 150 \text{ mA}, T_s = 85 \text{ °C}$)

ltem	Unit	Rank	Bin	Min.	Тур.	Max.
Forward Voltage (V _F)	V	6E	6A	2.7	-	2.9
Forward voltage (VF)	v	0⊏	AE	2.9	-	3.1
Reverse Voltage (@ -10 μA)	V			-10.0	-	-
Color Rendering Index (Ra)	-	8		80	-	-
Special CRI (R9)	-			0	-	-
Thermal Resistance (junction to chip point)	K/W			-	2	-
Beam Angle	0			-	120	-

Note: Samsung maintains measurement tolerance of : Forward voltage = ± 0.1 V, Luminous flux = ± 5 %, CRI = ± 3 , R9 = ± 6.5

c) Luminous Flux Characteristics	(IF = 150 mA, Ts = 85 °C)
----------------------------------	---------------------------

		S	A	S	В	S	С	S	D	S	SE	5	SF	S	G	S	Н	9	51
CRI	Nominal CCT (K)	Min.	Max.																
		43	47	47	51	51	55	55	59	59	63	63	67	67	71	71	75	75	79
	2700																		
	3000																		
	3500																		
70	4000																		
	5000																		
	5700																		
	6500																		
	2700																		
	3000																		
	3500																		
80	4000																		
	5000																		
	5700																		
	6500																		
	2700																		
	3000																		
90	3500																		
	4000																		
	5000																		

Note:

1) The LM101B is tested in pulsed condition at rated test current (10 ms pulse width)

2) Calculated flux values are for reference only

3) Samsung maintains measurement tolerance of: luminous flux = $\pm 5 \%$

2. Product Code Information (IF = 150 mA, Ts = 85 °C)

1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17	18
	С																

Digit	PKG Information	Code	Specification
1 2 3	Samsung Chip	SCP	
		7	Min. 70
4	CRI	8	Min. 80
		9	Min. 90
		w	2700
		v	3000
		U	3500
5	CCT (K)	т	4000
		R	5000
		Q	5700
		Р	6500
6	Chip Shape	т	Square
789	Chip Code	78H	
10 11 12	Product Purpose	EL1	FeC for Lighting
		w	2700K
		V	3000K
		U	3500K
13	CCT (K)	т	4000K
		R	5000K
		Q	5700K
		Р	6500K
14	MacAdam Step	L	Single Bin for MacAdam 5-step L(MacAdam 5-step Bin)
45 40		U	Single Bin for MacAdam 3-step U(MacAdam 3-step Bin)
15 16	Luminous Flux (Im)	S0	Code: 5Y, 5Z, 5A, 5B, SC, SD, SE, 5F, 5G, 5H
17 18	Forward Voltage (V)	6E	6A 2.7~2.9 2.7~3.1 Bin Code: AE 2.9~3.1

a) Luminous Flux Bins ($I_F = 150 \text{ mA}, T_s = 85 \text{ °C}$)

CRI (R₃) Min.	Nominal CCT (K)	Product Code	Flux Bin	Flux Range (Φ _v , Im)
			SE	59 ~ 63
	2700	SCP7WT78HEL1W☆S06E	SF	63 ~ 67
			SG	67 ~ 71
			SF	63 ~ 67
	3000	SCP7VT78HEL1V☆S06E	SG	67 ~ 71
			SH	71 ~ 75
			SF	63 ~ 67
	3500	SCP7UT78HEL1U☆S06E	SG	67 ~ 71
			SH	71 ~ 75
			SG	67 ~ 71
	4000	SCP7TT78HEL1T☆S06E	SH	71 ~ 75
70			SJ	75 ~ 79
			SG	67 ~ 71
	5000	SCP7RT78HEL1R☆S06E	SH	71 ~ 75
			SJ	75 ~ 79
			SF	63 ~ 67
	5700	SCP7QT78HEL1Q☆S06E	SG	67 ~ 71
			SH	71 ~ 75
			SF	63 ~ 67
	6500	SCP7PT78HEL1P☆S06E	SG	67 ~ 71
			SH	71 ~ 75

Note: "☆" can be "L" (Single bin for MacAdam 5-step), "U" (Single bin for MacAdam 3-step)

a) Luminous Flux Bins ($I_F = 150 \text{ mA}, T_s = 85 \text{ °C}$)

CRI (R₀) Min.	Nominal CCT (K)	Product Code	Flux Bin	Flux Range (Φ _v , Im)
			SE	59 ~ 63
	2700	SCP8WT78HEL1W☆S06E	SF	63 ~ 67
			SG	67 ~ 71
			SE	59 ~ 63
	3000	SCP8VT78HEL1V S06E	SF	63 ~ 67
			SG	67 ~ 71
			SF	63 ~ 67
	3500	SCP8UT78HEL1U☆S06E	SG	67 ~ 71
			SH	71 ~ 75
			SF	63 ~ 67
80	4000	SCP8TT78HEL1T ^A S06E	SG	67 ~ 71
			SH	71 ~ 75
			SF	63 ~ 67
	5000	SCP8RT78HEL1R☆S06E	SG	67 ~ 71
			SH	71 ~ 75
			SF	63 ~ 67
	5700	SCP8QT78HEL1Q☆S06E	SG	67 ~ 71
			SH	71 ~ 75
			SE	59 ~ 63
	6500	SCP8PT78HEL1P☆S06E	SF	63 ~ 67
			SG	67 ~ 71

Note: "☆" can be "L" (Single bin for MacAdam 5-step) "U" (Single bin for MacAdam 3-step)

a) Luminous Flux Bins ($I_F = 150 \text{ mA}, T_s = 85 \text{ °C}$)

CRI (R₃) Min.	Nominal CCT (K)	Product Code	Flux Bin	Flux Range (Φ _v , Im)
			SB	47 ~ 51
	2700	SCP9WT78HEL1W☆S06E	SC	51 ~ 55
			SD	55 ~ 59
			SB	47 ~ 51
	3000	SCP9VT78HEL1V☆S06E	SC	51 ~ 55
			SD	55 ~ 59
			SB	47 ~ 51
90	3500	SCP9UT78HEL1U☆S06E	SC	51 ~ 55
			SD	55 ~ 59
			SC	51 ~ 55
	4000	SCP9TT78HEL1T☆S06E	SD	55 ~ 59
			SE	59 ~ 63
			SC	51 ~ 55
	5000	SCP9RT78HEL1R☆S06E	SD	55 ~ 59
			SE	59 ~ 63

Note: "☆" can be "L" (Single bin for MacAdam 5-step), "U" (Single bin for MacAdam 3-step)

9

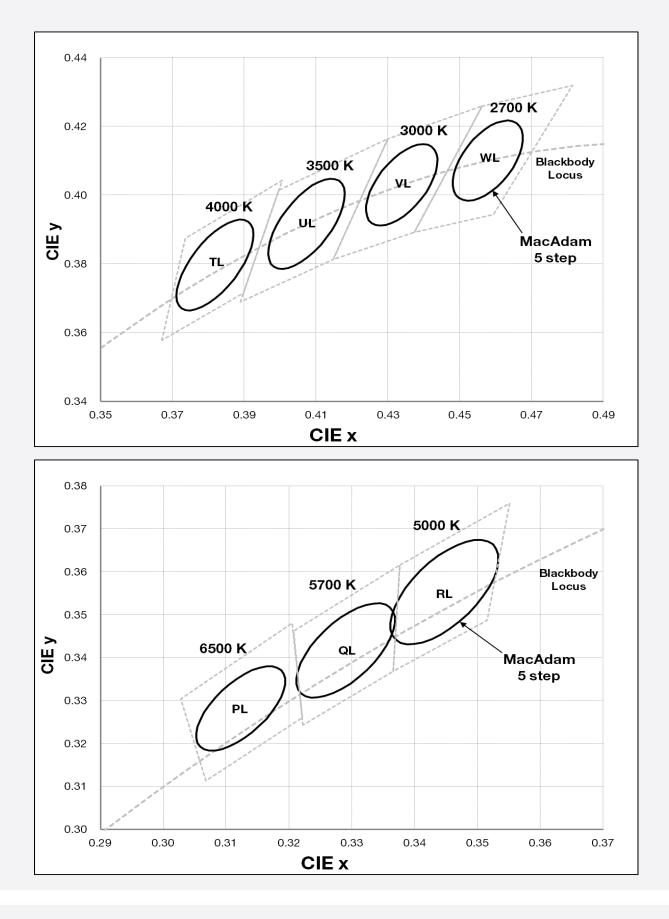
b) Color Bins ($I_F = 150 \text{ mA}, T_s = 85 \text{ }^{\circ}\text{C}$)

CRI Min.	Nominal CCT (K)	Product Code	Color Rank	Chromaticity Bins
	2700	SCP7WT78HEL1W ☆S06E	WL	WL
	2700		WU	WU
	3000	SCP7VT78HEL1V☆S06E	VL	VL
			VU	VU
	3500	SCP7UT78HE1U☆S06E	UL	UL
	3300		UU	UU
70	4000	SCP7TT78HEL1T☆S06E	TL	TL
70	4000	SCFTTTONELTT & SUCE	TU	TU
	5000	SCP7RT78HEL1R☆S06E	RL	RL
	3000	SCF / KT/OHLLIK # SUOL	RU	RU
	5700		QL	QL
	5700	SCP7QT78HEL1Q ☆ S06E	QU	QU
	0500		PL	PL
	6500	SCP7PT78HEL1P☆S06E	PU	PU
	2700	SCP8WT78HEL1W ☆ S06E	WL	WL
	2700	SCFOW IT OHELIW × SUCE	WU	WU
	3000		VL	VL
	3000	SCP8VT78HEL1V☆S06E	VU	VU
	0500		UL	UL
	3500	SCP8UT78HEL1U ☆ S06E	UU	UU
	4000		TL	TL
80	4000	SCP8TT78HEL1T☆S06E	TU	TU
	5000		RL	RL
	5000	SCP8RT78HEL1R☆S06E	RU	RU
		000007701/51/00 - 0005	QL	QL
	5700	SCP8QT78HEL1Q☆ S06E	QU	QU
			PL	PL
	6500	SCP8PT78HEL1P☆S06E	PU	PU
		0000011770	WL	WL
	2700	SCP9WT78HEL1W ☆ S06E	WU	WU
			VL	VL
	3000	SCP9VT78HEL1V☆S06E	VU	VU
			UL	UL
90	3500	SCP9UT78HEL1U ☆ S06E	UU	UU
			UL	UL
	4000	SCP9TT78HEL1T☆S06E	UU	UU
			UL	UL
	5000	SCP9RT78HEL1R ☆ S06E	UU	UU

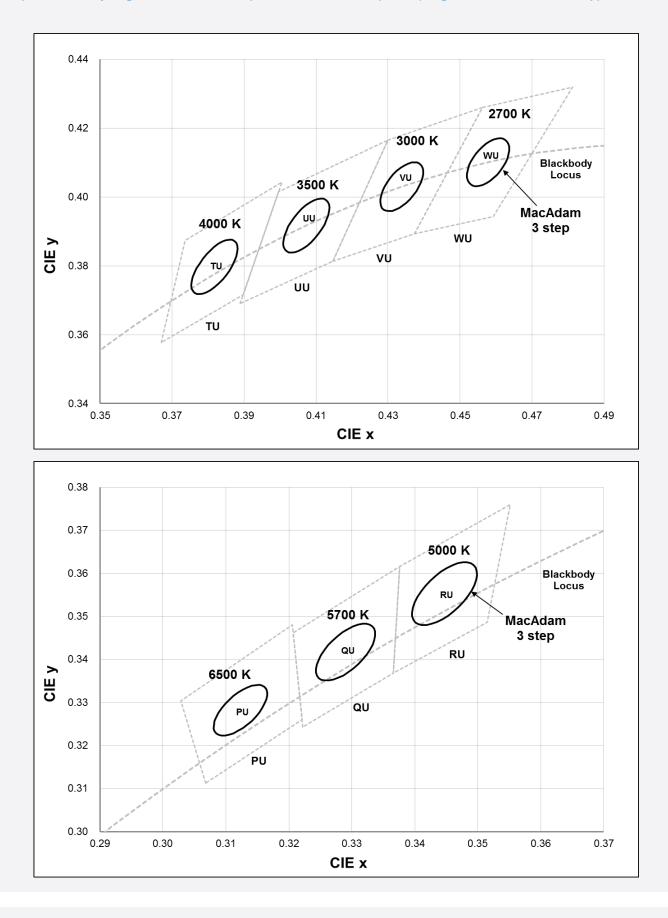
Note: "☆" can be "L" (Single bin for MacAdam 5-step), "U" (Single bin for MacAdam 3-step)

c) Voltage Bins ($I_F = 150 \text{ mA}, T_s = 85 \text{ }^{\circ}\text{C}$)

Nominal CCT (K)	CRI Min.	Product Code	Voltage Rank	Voltage Bin	Voltage Range (V)
				6A	2.7 ~ 2.9
			6E	AE	2.9 ~ 3.1

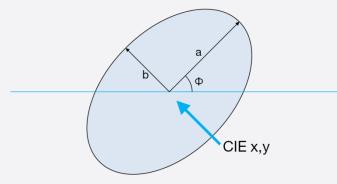


d) Chromaticity Region & Coordinates (I_F = 150 mA, T_s = 85 °C) : "L" (Single bin for MacAdam 5-step)



d) Chromaticity Region & Coordinates (I_F = 150 mA, T_s = 85 °C) : "U" (Single bin for MacAdam 3-step)

d) Chromaticity Region & Coordinates ($I_F = 150 \text{ mA}, T_s = 85 \text{ }^{\circ}\text{C}$)



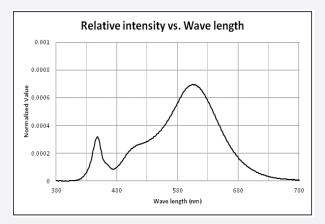
	сст	Center	point	int Major-axis		Rotation
	(К)	CIE x	CIE y	а		Φ
	2700	0.4578	0.4101	0.0081	0.0042	53.70
	3000	0.4338	0.4030	0.0083	0.0041	53.22
	3500	0.4073	0.3917	0.0093	0.0041	54.00
3 step (U code)	4000	0.3818	0.3797	0.0094	0.0040	53.72
	5000	0.3447	0.3553	0.0082	0.0035	59.62
	5700	0.3287	0.3417	0.0075	0.0032	59.10
	6500	0.3123	0.3282	0.0067	0.0029	58.57
	2700	0.4578	0.4101	0.0135	0.0070	53.70
	3000	0.4338	0.4030	0.0138	0.0068	53.22
	3500	0.4073	0.3917	0.0155	0.0068	54.00
5 step (L code)	4000	0.3818	0.3797	0.0157	0.0067	53.72
	5000	0.3447	0.3553	0.0137	0.0058	59.62
	5700	0.3287	0.3417	0.0125	0.0053	59.10
	6500	0.3123	0.3282	0.0112	0.0048	58.57
ote: Samsung mai	ntains measi	urement tolerance of	: Cx, Cy = ±0.005			

Note: Samsung maintains measurement tolerance of: Cx, $Cy = \pm 0.005$

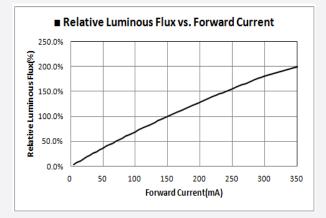
3. Typical Characteristics Graphs

a) Spectrum Distribution ($I_F = 150 \text{ mA}, T_s = 85 \text{ }^{\circ}\text{C}$)

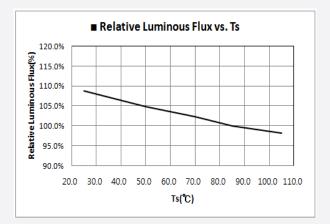
CCT: 2700 K, CRI80



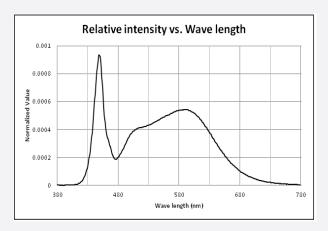
b) Forward Current Characteristics (T_s = 85 °C)

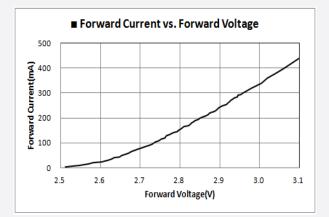


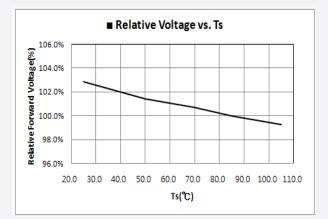
c) Temperature Characteristics ($I_F = 150 \text{ mA}$)



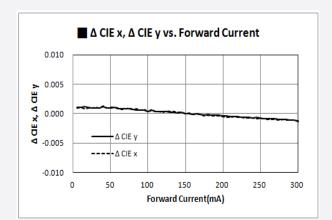
CCT: 5000 K, CRI80

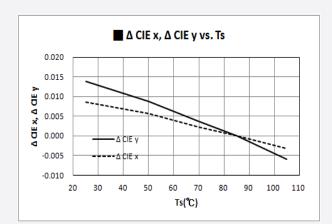




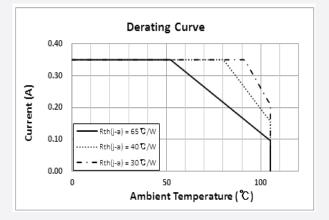






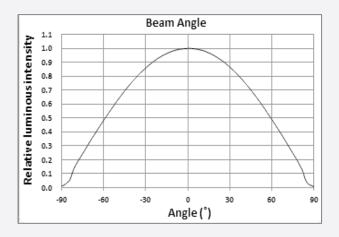


e) Derating Curve



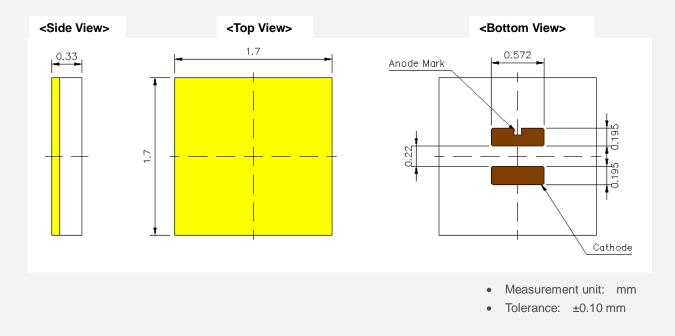
 R_{th} is measured after soldering of LED chip on the metal based substrate. *metal: aluminum (refer to page 17)

f) Beam Angle Characteristics (I_F =150 mA)



4. Outline Drawing & Dimension

- 1. Tolerance is ±0.10 mm
- 2. Do not place LEDs with pressure



Precautions:

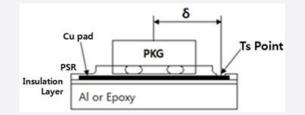
- Pressure on the LEDs will influence to the reliability of the LEDs. Precautions should be taken to avoid strong pressure on the LEDs. Do not put stress on the LEDs during heating.
- 2) Re-soldering should not be done after the LEDs have been soldered. If re-soldering is unavoidable, LED's characteristics should be carefully checked before and after such repair.
- Do not stack assembled PCBs together. Since materials of LEDs is soft, abrasion between two PCB assembled with LED might cause catastrophic failure of the LEDs.

Ts Point & Measurement Method:

Measure nearest point from the center of LED chip (δ) as shown below.

Distance between chip center and T_s point (δ) = 3.5 mm

 $T_j = T_s + Power x$ Thermal resistance at $T_s (R_{j-s})$



Precautions:

- 4) This LED chip PKG does not contain built-in ESD protection device.
- 5) Pressure on the LEDs will influence to the reliability of the LEDs. Precautions should be taken to avoid strong pressure on the LEDs. Do not put stress on the LEDs during heating.
- Re-soldering should not be done after the LEDs have been soldered. If re-soldering is unavoidable, LED's characteristics should be carefully checked before and after such repair.
- 7) Do not stack assembled PCBs together. Since materials of LEDs is soft, abrasion between two PCB assembled with LED might cause catastrophic failure of the LEDs

5. Reliability Test Items & Conditions

a) Test Items

Test Item	Test Condition	Test Hour / Cycle
Room Temperature Life Test	25 °C, Derated max current	1000 h
High Temperature Life Test	85 °C, Derated max current	1000 h
High Temperature Humidity Life Test	85 °C, 85 % RH, Derated max current	1000 h
Low Temperature Life Test	-40 °C, DC Derated max current	1000 h
Powered Temperature Cycle Test	-45 °C / 20 min ↔ 85 °C / 20 min, sweep 100 min cycle on/off: each 5 min, Derated max current	100 cycles
Temperature Cycling	-45 °C / 15 min ↔ 125 °C / 15 min → Hot plate 180 °C	500 cycles
High Temperature Storage	120 °C	1000 h
Low Temperature Storage	-40 °C	1000 h
ESD (HBM)	R1 10 ΜΩ R2 1.5 KΩ C 100 pF W ±2 kV	5 times
Vibration Test	20~2000~20 Hz, 200 m/s ² , sweep 4 min X, Y, Z 3 direction, each 1 cycle	4 cycles
Mechanical Shock Test	1500 g, 0.5 ms	5 cycles

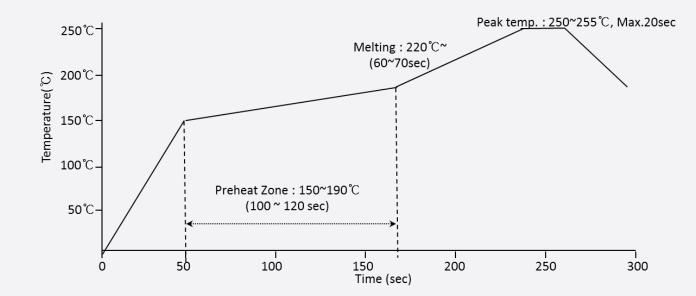
b) Criteria for Judging the Damage

ltem	Symbol	Test Condition (T _s = 25 °C)	Limit		
Item			Min	Max	
Forward Voltage	VF	I_F = Derated max current	Init. Value * 0.9	Init. Value * 1.1	
Luminous Flux	Φν	I_F = Derated max current	Init. Value * 0.7	Init. Value * 1.1	

6. Soldering Conditions

a) Reflow Conditions (Pb free)

Reflow frequency: 2 times max.



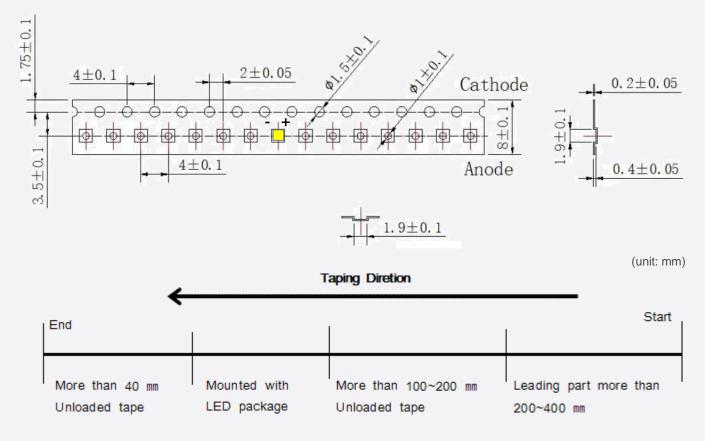
b) Manual Soldering Conditions

Not more than 5 seconds @ max. 300 °C, under soldering iron

20

7. Tape & Reel

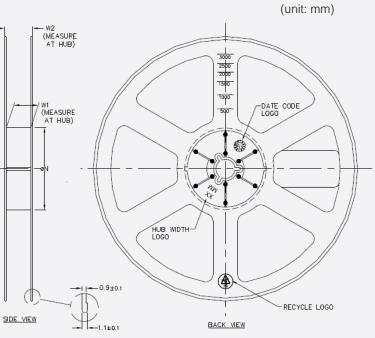
a) Taping Dimension

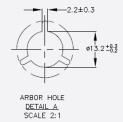


21

b) Reel Dimension

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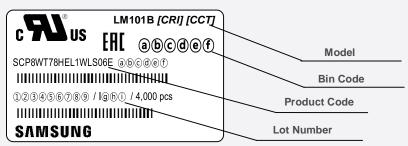
	PRODUCT SPECIFICATIONS				
	TAPE WIDTH	ØA ±1.0	øN ±0.5	W1 ±0.5	W2 (MAX)
	08MM	ø178.0	54.0	9.5	15.0
、	12MM	ø178.0	54.0	13.5	19.0

Notes:

- 1) Quantity: 4,000 Qty/reel
- 2) Cumulative tolerance: Cumulative tolerance / 10 pitches is ±0.2 mm
- 3) Packaging: P/N, Manufacturing data code no. and quantity are indicated on the aluminum packing bag

8. Label Structure

a) Label Structure



Note: Denoted product code and bin code above is only an example

Bin Code:

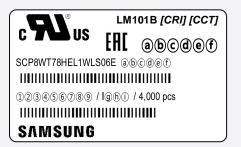
ab:	Chromaticity	bin (re	fer to p	age 10-14)
-----	--------------	---------	----------	------------

©d: Luminous Flux bin (refer to page 7-9)

(e)(f): Forward Voltage bin (refer to page 11)

b) Lot Number

The lot number is composed of the following characters:

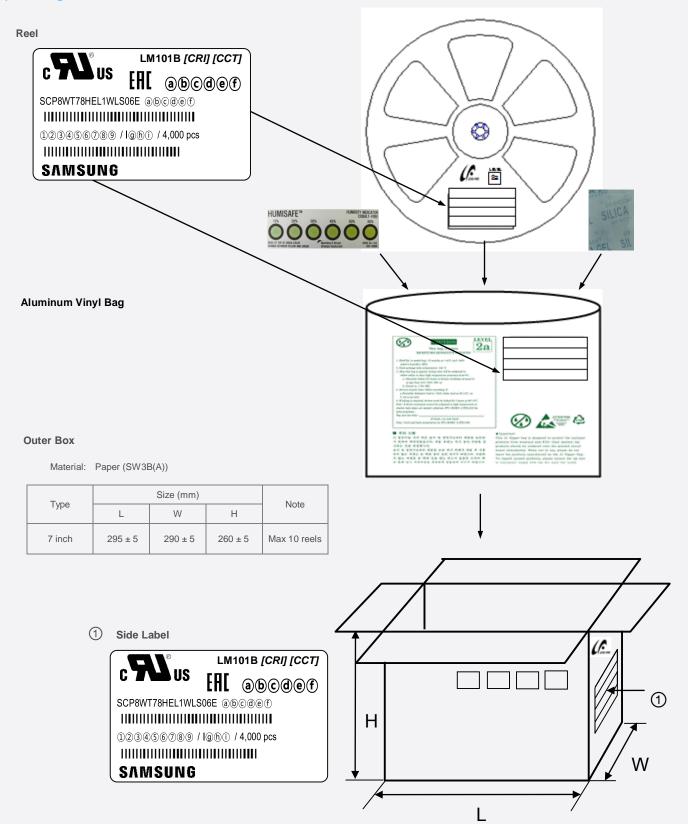


123456789 / Iabc / 4,000 pcs

1 2	: Production site (GB: Nanchang China)
3	: Product state (A: Normal, B: Bulk, C: First Production, R: Reproduction, S: Sample)
4	: Year (Z: 2015, A: 2016,, E: 2020,)
5	: Month (1~9, A, B, C)
6	: Day (1~9, A, B~V)
789	: Product serial number (001 ~ 999)
9bi)	: Reel number (001 ~ 999) or (AAA ~ ZZZ)

9. Packing Structure

a) Packing Process

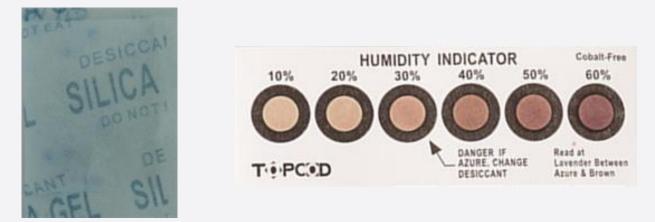


24

b) Aluminum Vinyl Packing Bag



c) Silica Gel & Humidity Indicator Card inside Aluminum Vinyl Bag



25

10. Precautions in Handling & Use

- 1) For over-current-proof function, customers are recommended to apply resistors to prevent sudden change of the current caused by slight shift of the voltage.
- 2) This device should not be used in any type of fluid such as water, oil, organic solvent, etc. When washing is required, IPA is recommended to use.
- 3) When the LEDs illuminate, operating current should be decided after considering the ambient maximum temperature.
- 4) LEDs must be stored in a clean environment.
- After storage bag is opened, device subjected to soldering, solder reflow, or other high temperature processes must be:
 a. Mounted within 672 hours (28 days) at an assembly line with a condition of no more than 30 °C / 60 % RH, or
 b. Stored at <10 % RH
- 6) Repack unused products with anti-moisture packing, fold to close any opening and then store in a dry place.
- 7) Devices require baking before mounting, if humidity card reading is >60 % at 23 ± 5 °C.
- 8) Devices must be baked for 1 hour at 60 ± 5 °C, if baking is required.
- 9) The LEDs are sensitive to the static electricity and surge. It is recommended to use a wrist band or anti-electrostatic glove when handling the LEDs. If voltage exceeding the absolute maximum rating is applied to LEDs, it may cause damage or even destruction to LED devices. Damaged LEDs may show some unusual characteristics such as increase in leak current, lowered turn-on voltage, or abnormal lighting of LEDs at low current.
- 10) VoCs (Volatile Organic Compounds) can be generated from adhesives, flux, hardener or organic additives used in luminaires (fixtures). LED silicone encapsulant is permeable to those chemicals and they may lead to a discoloration of encapsulant when they exposed to heat or light. This phenomenon can cause a significant loss of light emitted (output) from the luminaires. In order to prevent these problems, we recommend users to know the physical properties of materials used in luminaires and they must be carefully selected.
- 11) Risk of sulfurization (or tarnishing)

The LED from Samsung does not use a silver-plated lead frame but if the LED is attached in silver-plated substrate, the surface color of substrate may change to black (or dark colored) when it is exposed to sulfur (S), chlorine (Cl) or other halogen compound. Sulfurization of substrate may cause intensity degradation, change of chromaticity coordinates and, in extreme cases, open circuit, It requires caution. Due to possible sulfurization of substrate, LED should not be used and stored together with oxidizing substances made of materials such as rubber, plain paper, lead solder cream, etc.

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Samsung Electronics Co., Ltd. 95, Samsung 2-ro Giheung-gu Yongin-si, Gyeonggi-do, 446-711 KOREA

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